Search Notes



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Applicant(s)/Patent Under Reexamination

TAKAYAMA ET AL.

Examiner

Art Unit

Examinei

Wang, Chang-Yu

1649

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST, STN: search strategy attached (updated).	12/21/09	CYW		
Inventor name search: EAST, STN, PALM (updated).	12/21/09	CYW		
PLUS search from STIC. see search results in eDAN (11/30/09)	12/21/09	CYW		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

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